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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Hideo ANDO, et al.

SERIAL NO: 10/076,325

GAU: 2615

FILED: February 19, 2002

EXAMINER: Not Assigned

FOR: INFORMATION STORAGE SYSTEM CAPABLE OF RECORDING AND PLAYING BACK A PLURALITY OF STILL PICTURES

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

ASSISTANT COMMISSIONER FOR PATENTS
WASHINGTON, D.C. 20231

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- ☒ The applicant(s) wish to make of record the 8 references listed on the attached form PTO-1449, cited in the 5 attached Explanations of Circumstances Concerning Accelerated Examination for: Japanese Patent No.'s 2001-310033 (filed in the Japanese Patent Office July 1, 2002) 2001-310034 (filed in the JPO June 25, 2002), 2001-310035 (filed in the JPO July 15, 2002), 2001-310036 (filed in the JPO July 15, 2002), and 2001-310037 (filed in the JPO July 15, 2002). Copies of the cited references (with English translations) are attached, as are English translations for said Explanations.

- ☐ A check is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- ☐ Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- ☐ A check is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

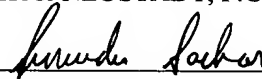
- ☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- ☐ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

- ☒ Please charge any additional fees for the papers being filed herewith and for which no check is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
219517US2SDIVSERIAL NO.
10/076,325

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Hideo ANDO, et al.FILING DATE
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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	6,385,389 B1	07May02	Maruyama et al.			
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AG	EP 1 065 665 A1	03Jan01	European Patent Office (in English)		
	AH	JP 5-81787	02Apr93	JAPAN	x	
	AI	JP 7-143429	02Jun95	JAPAN	x	
	AJ	JP 8-106721	23Apr96	JAPAN	x	
	AK	JP 9-259539	03Oct97	JAPAN	x	
	AL	JP 11-215471	6Aug99	JAPAN (corresponding U.S. Patent no. 6,385,389 B1 Maruyama, et al.)		x
	AM	JP 11-238362	31Aug99	JAPAN (corresponding European Patent No. EP 1 065 665, ANDO, et al.)		x
	AN					
	AO					
	AP					
	AQ					
	AR					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AS	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310033 (with English translation)
	AT	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310034 (with English translation)
	AU	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310035 (with English translation)
	AV	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310036 (with English translation)
	AW	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310037 (with English translation)
	AX	<input type="checkbox"/> Additional References sheet(s) attached

Examiner

Date Considered

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.